


<p><i>Search Notes</i></p> 	<p>Application/Control No.</p> <p>10656625</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>DAWIDOWSKY ET AL.</p>
	<p>Examiner</p> <p>Foud, Hicham B</p>	<p>Art Unit</p> <p>2419</p>

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
UPDATE EAST SEARCH (Search 370/442-444 with text)	2/18/2009	HF
GOOGLE SEARCH	2/18/2009	HF
WWW.IETF.ORG	2/18/2009	HF
Text Search	2/18/2009	HF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

<p>/HICHAM B FOUD/ Examiner.Art Unit 2419</p>	
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